Applicant(s)/Patent Under Application/Control No. Reexamination 10/675,441 CHEN ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 David Vu 2828 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,593,703 07-2003 Sun, Yiyoung 315/224 Α В US-5,491,386 02-1996 Eriguchi et al. 315/209R US-С US-D US-Ε US-F US-G Н US-US-US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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